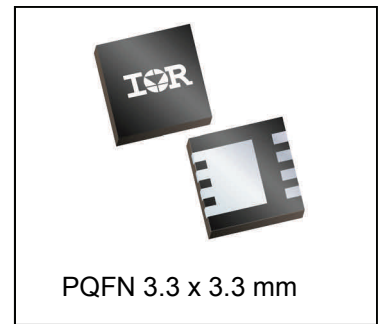
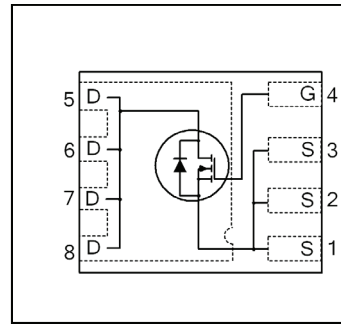


HEXFET® Power MOSFET

|                                                            |              |           |
|------------------------------------------------------------|--------------|-----------|
| <b>V<sub>DSS</sub></b>                                     | <b>25</b>    | <b>V</b>  |
| <b>R<sub>DS(on)</sub> max</b><br>(@ V <sub>GS</sub> = 10V) | <b>2.2</b>   | <b>mΩ</b> |
| (@ V <sub>GS</sub> = 4.5V)                                 | <b>3.3</b>   |           |
| <b>Qg</b> (typical)                                        | <b>16</b>    | <b>nC</b> |
| <b>I<sub>D</sub></b><br>(@T <sub>C (Bottom)</sub> = 25°C)  | <b>60</b> ⓈⓉ | <b>A</b>  |



## Applications

- Control or Synchronous MOSFET for high frequency buck converters

## Features

|                                                   |
|---------------------------------------------------|
| Low R <sub>DS(on)</sub> (<2.2mΩ)                  |
| Low Charge (typical 16nC)                         |
| Low Thermal Resistance to PCB (<3.2°C/W)          |
| Low Profile (<0.9 mm)                             |
| Industry-Standard Pinout                          |
| Compatible with Existing Surface Mount Techniques |
| RoHS Compliant, Halogen-Free                      |
| MSL1                                              |

results in



## Benefits

|                                   |
|-----------------------------------|
| Lower Conduction Losses           |
| Low Switching Losses              |
| Enable better thermal dissipation |
| Increased Power Density           |
| Multi-Vendor Compatibility        |
| Easier Manufacturing              |
| Environmentally Friendlier        |
| Increased Reliability             |

| Base part number | Package Type       | Standard Pack |          | Orderable Part Number |
|------------------|--------------------|---------------|----------|-----------------------|
|                  |                    | Form          | Quantity |                       |
| IRFHM4226TRPbF   | PQFN 3.3mm x 3.3mm | Tape and Reel | 4000     | IRFHM4226TRPbF        |

## Absolute Maximum Ratings

|                                                 | Parameter                                                                              | Max.         | Units |
|-------------------------------------------------|----------------------------------------------------------------------------------------|--------------|-------|
| V <sub>GS</sub>                                 | Gate-to-Source Voltage                                                                 | ± 20         | V     |
| I <sub>D</sub> @ T <sub>A</sub> = 25°C          | Continuous Drain Current, V <sub>GS</sub> @ 10V                                        | 28           | A     |
| I <sub>D</sub> @ T <sub>C(Bottom)</sub> = 25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V                                        | 105ⓈⓉ        |       |
| I <sub>D</sub> @ T <sub>C(Bottom)</sub> = 100°C | Continuous Drain Current, V <sub>GS</sub> @ 10V                                        | 67ⓈⓉ         |       |
| I <sub>D</sub> @ T <sub>C</sub> = 25°C          | Continuous Drain Current, V <sub>GS</sub> @ 10V<br>(Source Bonding Technology Limited) | 60ⓈⓉ         |       |
| I <sub>DM</sub>                                 | Pulsed Drain Current ①                                                                 | 420Ⓢ         |       |
| P <sub>D</sub> @ T <sub>A</sub> = 25°C          | Power Dissipation ⑤                                                                    | 2.7          | W     |
| P <sub>D</sub> @ T <sub>C(Bottom)</sub> = 25°C  | Power Dissipation ⑤                                                                    | 39           |       |
|                                                 | Linear Derating Factor ⑤                                                               | 0.021        | W/°C  |
| T <sub>J</sub><br>T <sub>STG</sub>              | Operating Junction and<br>Storage Temperature Range                                    | -55 to + 150 | °C    |

Notes ① through ⑤ are on page 8

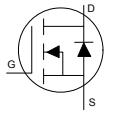
**Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

|                              | Parameter                                  | Min. | Typ. | Max. | Units                | Conditions                                                        |
|------------------------------|--------------------------------------------|------|------|------|----------------------|-------------------------------------------------------------------|
| $BV_{DSS}$                   | Drain-to-Source Breakdown Voltage          | 25   | —    | —    | V                    | $V_{GS} = 0V, I_D = 250\mu A$                                     |
| $\Delta BV_{DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient        | —    | 21   | —    | mV/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$              |
| $R_{DS(on)}$                 | Static Drain-to-Source On-Resistance       | —    | 1.7  | 2.2  | m $\Omega$           | $V_{GS} = 10V, I_D = 30A$ ③                                       |
|                              |                                            | —    | 2.6  | 3.3  |                      | $V_{GS} = 4.5V, I_D = 30A$ ③                                      |
| $V_{GS(th)}$                 | Gate Threshold Voltage                     | 1.1  | 1.6  | 2.1  | V                    | $V_{DS} = V_{GS}, I_D = 50\mu A$                                  |
| $\Delta V_{GS(th)}$          | Gate Threshold Voltage Coefficient         | —    | -5.7 | —    | mV/ $^\circ\text{C}$ |                                                                   |
| $I_{DSS}$                    | Drain-to-Source Leakage Current            | —    | —    | 1.0  | $\mu A$              | $V_{DS} = 20V, V_{GS} = 0V$                                       |
| $I_{GSS}$                    | Gate-to-Source Forward Leakage             | —    | —    | 100  | nA                   | $V_{GS} = 20V$                                                    |
|                              | Gate-to-Source Reverse Leakage             | —    | —    | -100 |                      | $V_{GS} = -20V$                                                   |
| $g_{fs}$                     | Forward Transconductance                   | 136  | —    | —    | S                    | $V_{DS} = 10V, I_D = 30A$                                         |
| $Q_g$                        | Total Gate Charge                          | —    | 32   | —    | nC                   | $V_{GS} = 10V, V_{DS} = 13V, I_D = 30A$                           |
| $Q_g$                        | Total Gate Charge                          | —    | 16   | 24   | nC                   | $V_{DS} = 13V$<br>$V_{GS} = 4.5V$<br>$I_D = 30A$                  |
| $Q_{gs1}$                    | Pre-V <sub>th</sub> Gate-to-Source Charge  | —    | 3.6  | —    |                      |                                                                   |
| $Q_{gs2}$                    | Post-V <sub>th</sub> Gate-to-Source Charge | —    | 2.0  | —    |                      |                                                                   |
| $Q_{gd}$                     | Gate-to-Drain Charge                       | —    | 5.8  | —    |                      |                                                                   |
| $Q_{godr}$                   | Gate Charge Overdrive                      | —    | 4.6  | —    |                      |                                                                   |
| $Q_{sw}$                     | Switch Charge ( $Q_{gs2} + Q_{gd}$ )       | —    | 7.8  | —    | nC                   | $V_{DS} = 16V, V_{GS} = 0V$                                       |
| $Q_{oss}$                    | Output Charge                              | —    | 15   | —    |                      |                                                                   |
| $R_G$                        | Gate Resistance                            | —    | 1.1  | —    | $\Omega$             |                                                                   |
| $t_{d(on)}$                  | Turn-On Delay Time                         | —    | 11   | —    | ns                   | $V_{DD} = 13V, V_{GS} = 4.5V$<br>$I_D = 30A$<br>$R_G = 1.8\Omega$ |
| $t_r$                        | Rise Time                                  | —    | 35   | —    |                      |                                                                   |
| $t_{d(off)}$                 | Turn-Off Delay Time                        | —    | 14   | —    |                      |                                                                   |
| $t_f$                        | Fall Time                                  | —    | 8.1  | —    |                      |                                                                   |
| $C_{iss}$                    | Input Capacitance                          | —    | 2000 | —    | pF                   | $V_{GS} = 0V$<br>$V_{DS} = 13V$<br>$f = 1.0\text{MHz}$            |
| $C_{oss}$                    | Output Capacitance                         | —    | 570  | —    |                      |                                                                   |
| $C_{rss}$                    | Reverse Transfer Capacitance               | —    | 150  | —    |                      |                                                                   |

**Avalanche Characteristics**

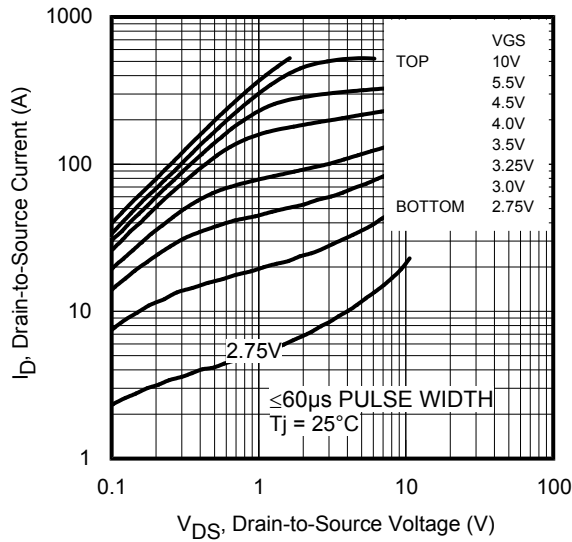
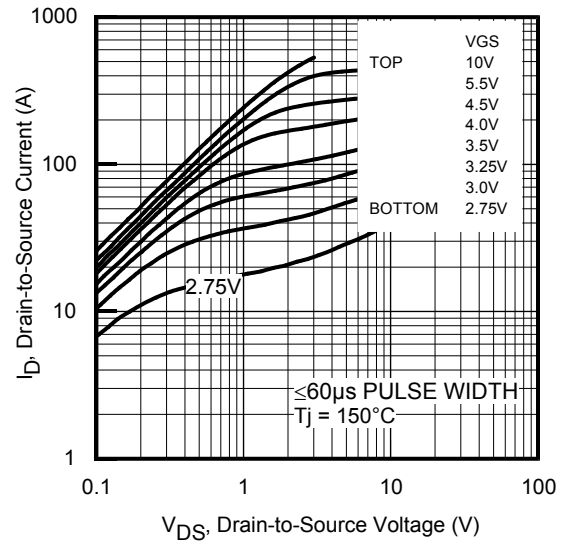
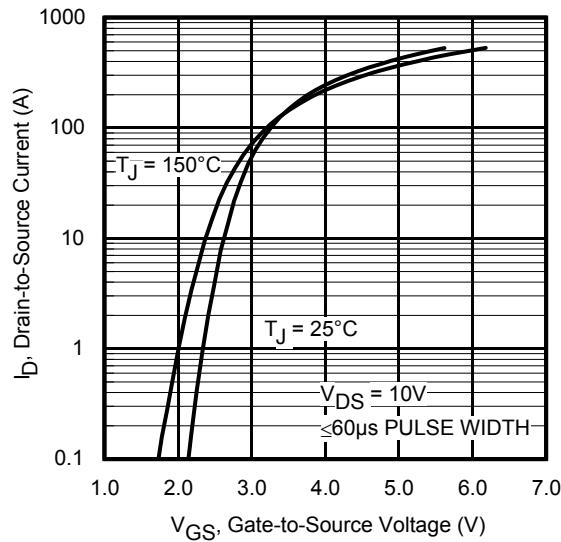
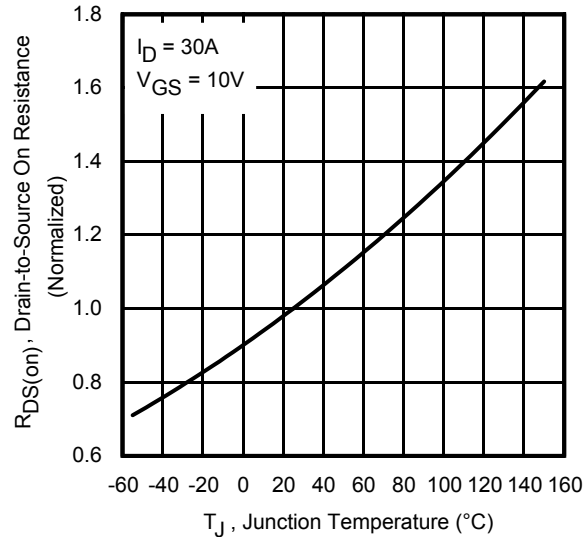
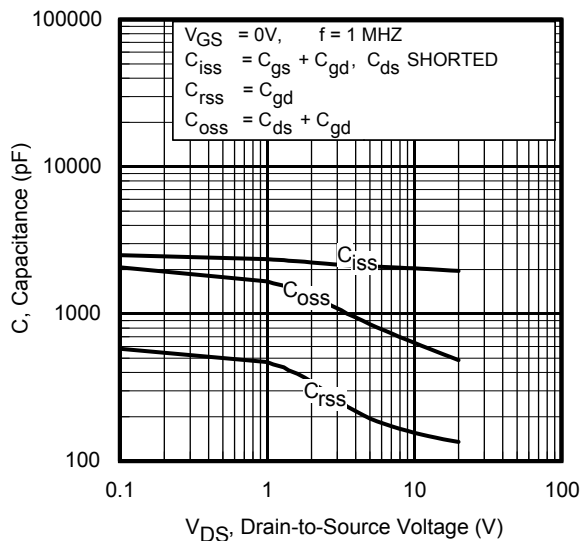
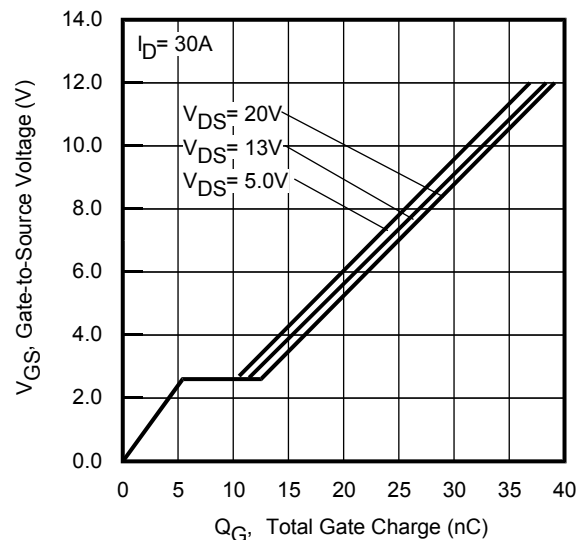
|          | Parameter                       | Typ. | Max. | Units |
|----------|---------------------------------|------|------|-------|
| $E_{AS}$ | Single Pulse Avalanche Energy ② | —    | 124  | mJ    |
| $I_{AR}$ | Avalanche Current ①             | —    | 30   | A     |

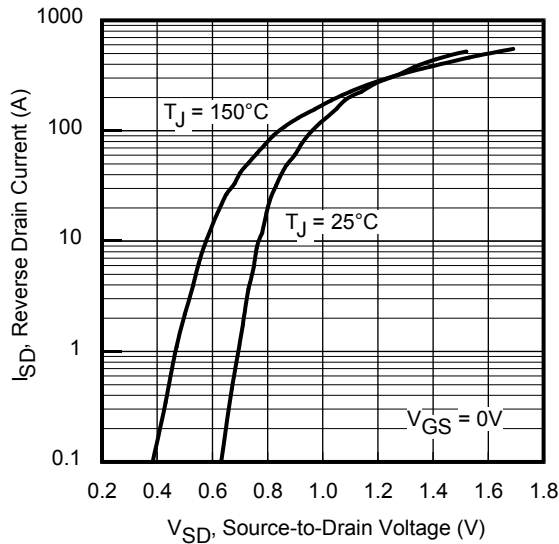
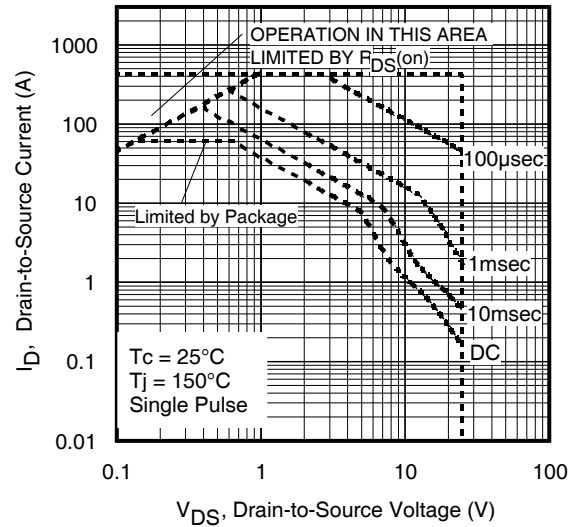
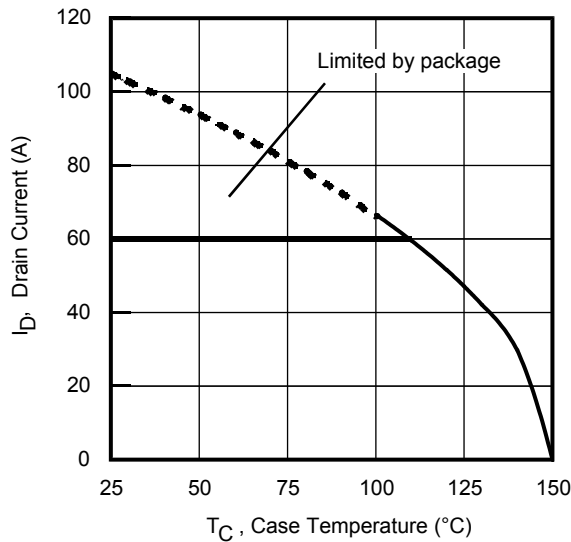
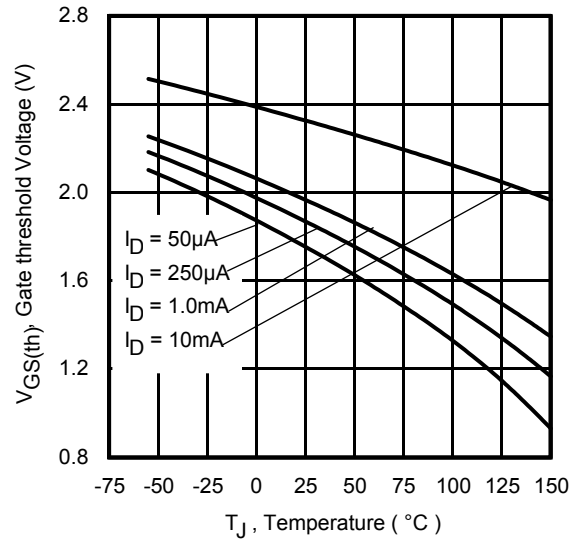
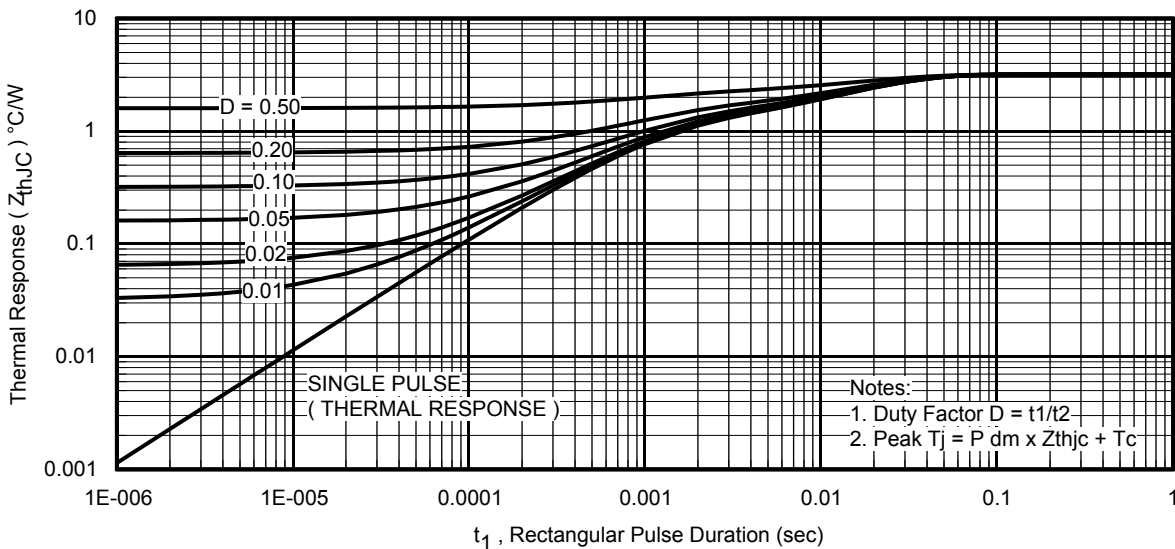
**Diode Characteristics**

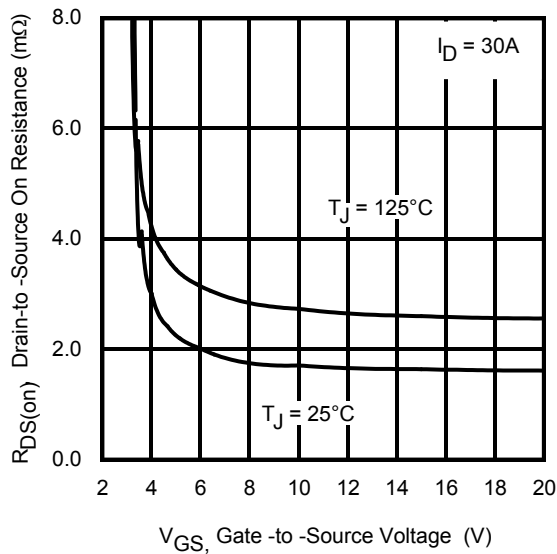
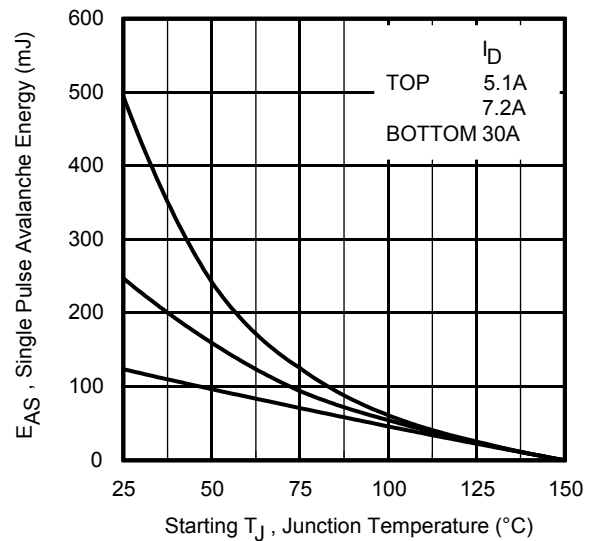
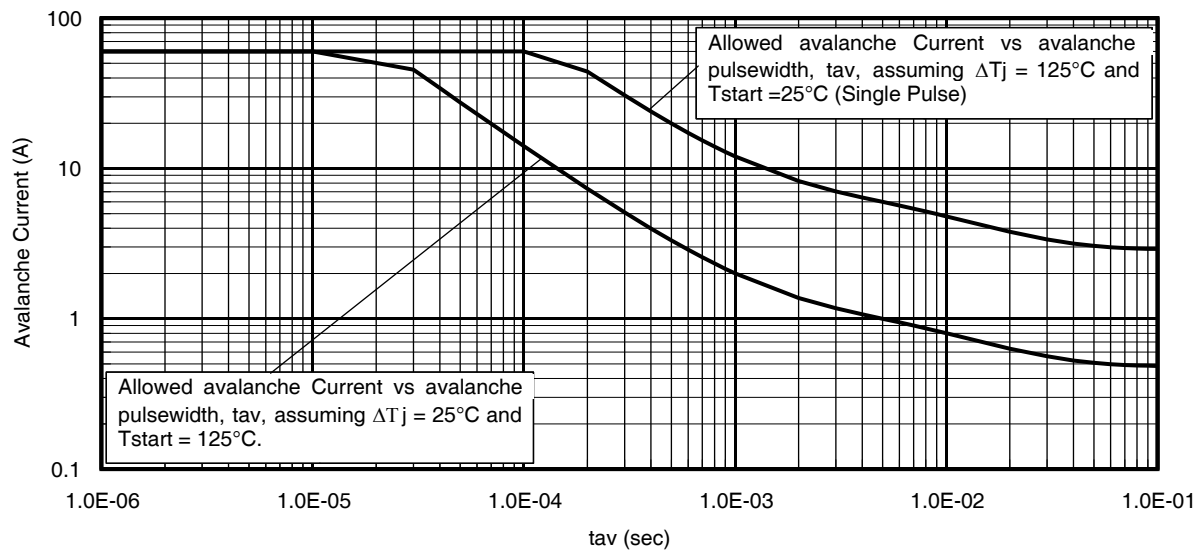
|          | Parameter                              | Min. | Typ. | Max. | Units | Conditions                                                                                                                                           |
|----------|----------------------------------------|------|------|------|-------|------------------------------------------------------------------------------------------------------------------------------------------------------|
| $I_S$    | Continuous Source Current (Body Diode) | —    | —    | 60⑥⑦ | A     | MOSFET symbol showing the integral reverse p-n junction diode.  |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —    | —    | 420⑧ |       |                                                                                                                                                      |
| $V_{SD}$ | Diode Forward Voltage                  | —    | —    | 1.0  | V     | $T_J = 25^\circ\text{C}, I_S = 30A, V_{GS} = 0V$ ③                                                                                                   |
| $t_{rr}$ | Reverse Recovery Time                  | —    | 16   | 24   | ns    | $T_J = 25^\circ\text{C}, I_F = 30A, V_{DD} = 13V$                                                                                                    |
| $Q_{rr}$ | Reverse Recovery Charge                | —    | 28   | 42   | nC    | $di/dt = 450A/\mu s$ ③                                                                                                                               |

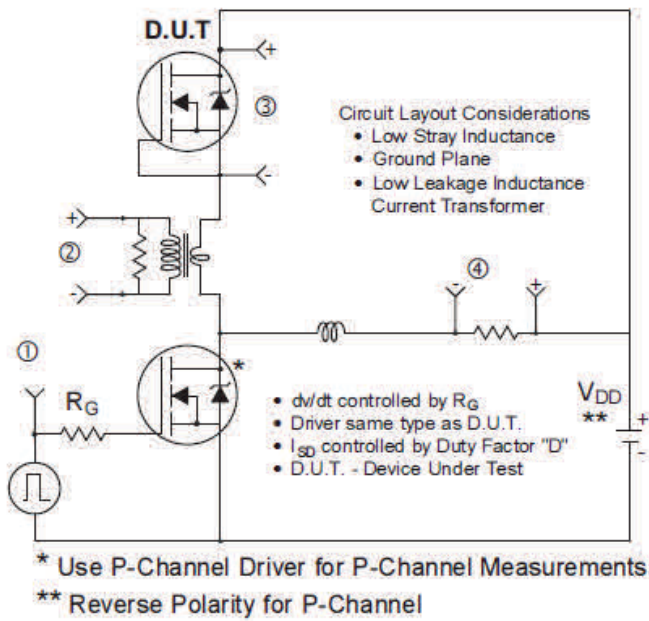
**Thermal Resistance**

|                          | Parameter             | Typ. | Max. | Units              |
|--------------------------|-----------------------|------|------|--------------------|
| $R_{\theta JC}$ (Bottom) | Junction-to-Case ④    | —    | 3.2  | $^\circ\text{C/W}$ |
| $R_{\theta JC}$ (Top)    | Junction-to-Case ④    | —    | 35   |                    |
| $R_{\theta JA}$          | Junction-to-Ambient ⑤ | —    | 47   |                    |
| $R_{\theta JA} (<10s)$   | Junction-to-Ambient ⑤ | —    | 30   |                    |

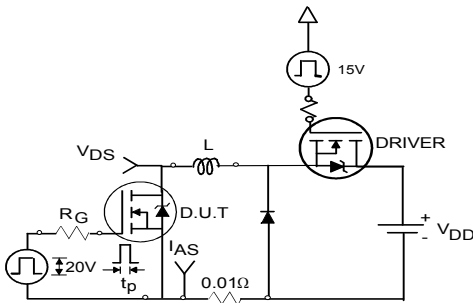
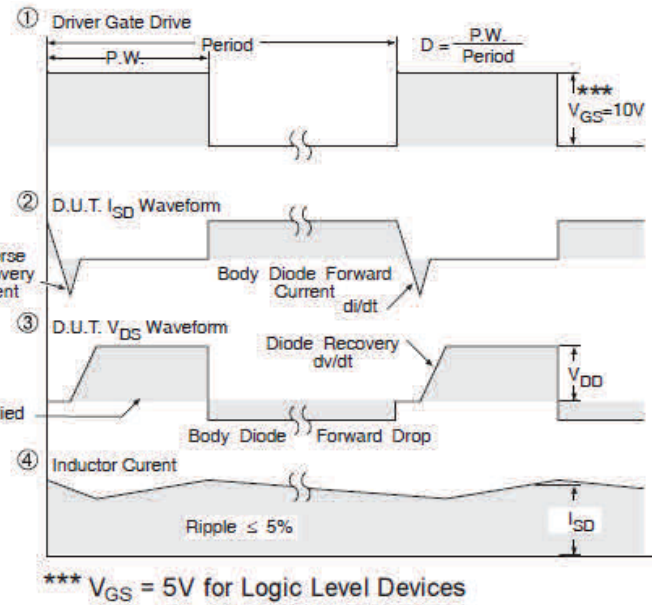

**Fig 1.** Typical Output Characteristics

**Fig 2.** Typical Output Characteristics

**Fig 3.** Typical Transfer Characteristics

**Fig 4.** Normalized On-Resistance vs. Temperature

**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage

**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage


**Fig 7.** Typical Source-Drain Diode Forward Voltage

**Fig 8.** Maximum Safe Operating Area

**Fig 9.** Maximum Drain Current vs. Case Temperature

**Fig 10.** Threshold Voltage Vs. Temperature

**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

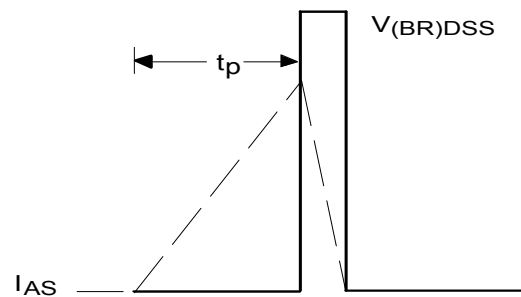

**Fig 12.** On-Resistance vs. Gate Voltage

**Fig 13.** Maximum Avalanche Energy vs. Drain Current

**Fig 14.** Single Avalanche Current vs. pulse Width



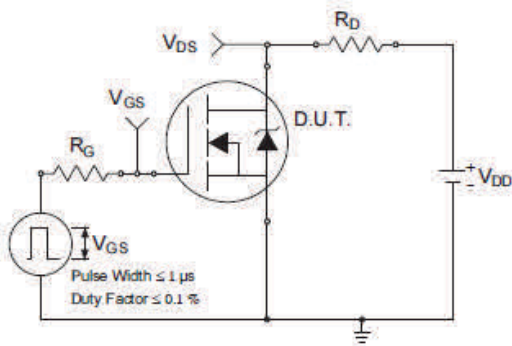
**Fig 15. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs**



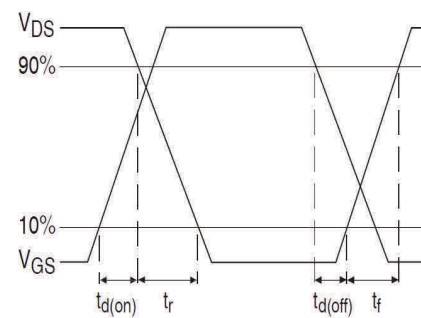
**Fig 16a. Unclamped Inductive Test Circuit**



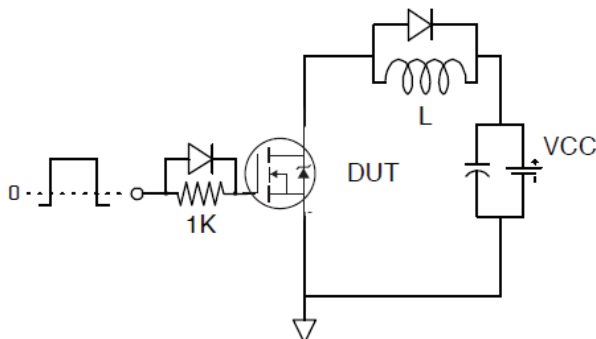
**Fig 16b. Unclamped Inductive Waveforms**



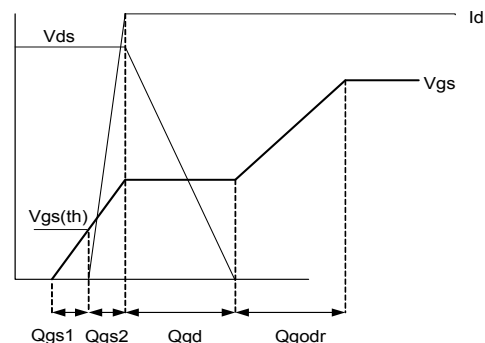
**Fig 17a. Switching Time Test Circuit**



**Fig 17b. Switching Time Waveforms**

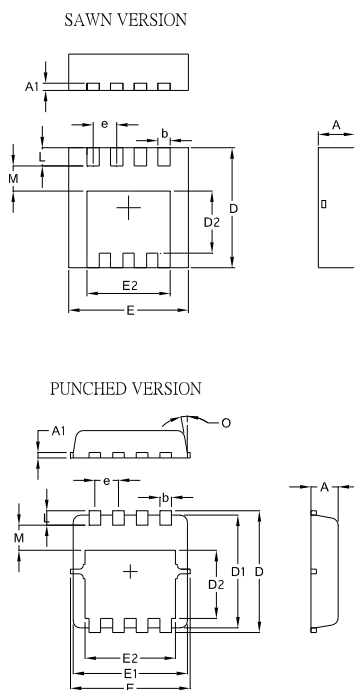


**Fig 18. Gate Charge Test Circuit**



**Fig 19. Gate Charge Waveform**

## PQFN 3.3 x 3.3 Package Details

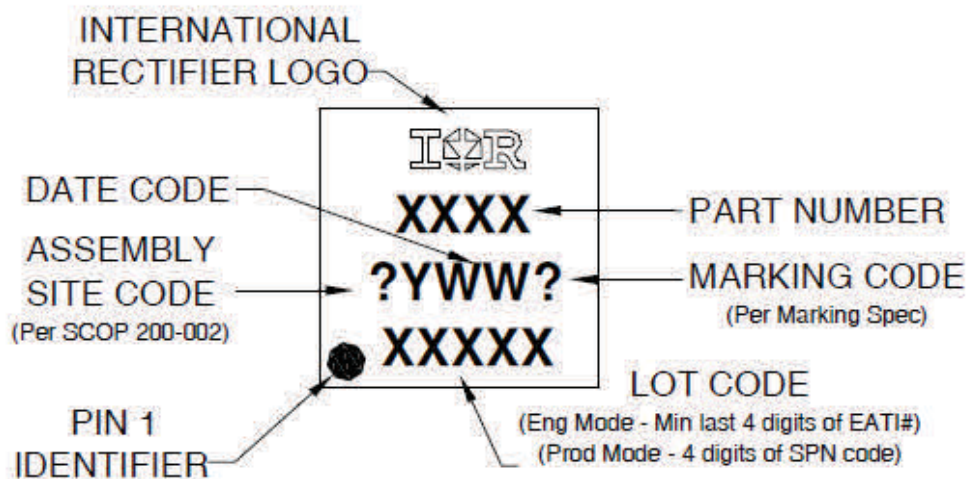


| SYMBOL | COMMON   |       |            |        |
|--------|----------|-------|------------|--------|
|        | MM       |       | INCH       |        |
|        | MIN.     | MAX.  | MIN.       | MAX.   |
| A      | 0.70     | 1.05  | 0.0276     | 0.0413 |
| A1     | 0.12     | 0.39  | 0.0047     | 0.0154 |
| b      | 0.25     | 0.39  | 0.0098     | 0.0154 |
| D      | 3.20     | 3.45  | 0.1260     | 0.1358 |
| D1     | 3.00     | 3.20  | 0.1181     | 0.1417 |
| D2     | 1.69     | 2.20  | 0.0665     | 0.0866 |
| E      | 3.20     | 3.40  | 0.1260     | 0.1339 |
| E1     | 3.00     | 3.20  | 0.1181     | 0.1417 |
| E2     | 2.15     | 2.59  | 0.0846     | 0.1020 |
| e      | 0.65 BSC |       | 0.0256 BSC |        |
| L      | 0.15     | 0.55  | 0.0059     | 0.0217 |
| M      | 0.59     | —     | 0.0232     | —      |
| O      | 9Deg     | 12Deg | 9Deg       | 12Deg  |

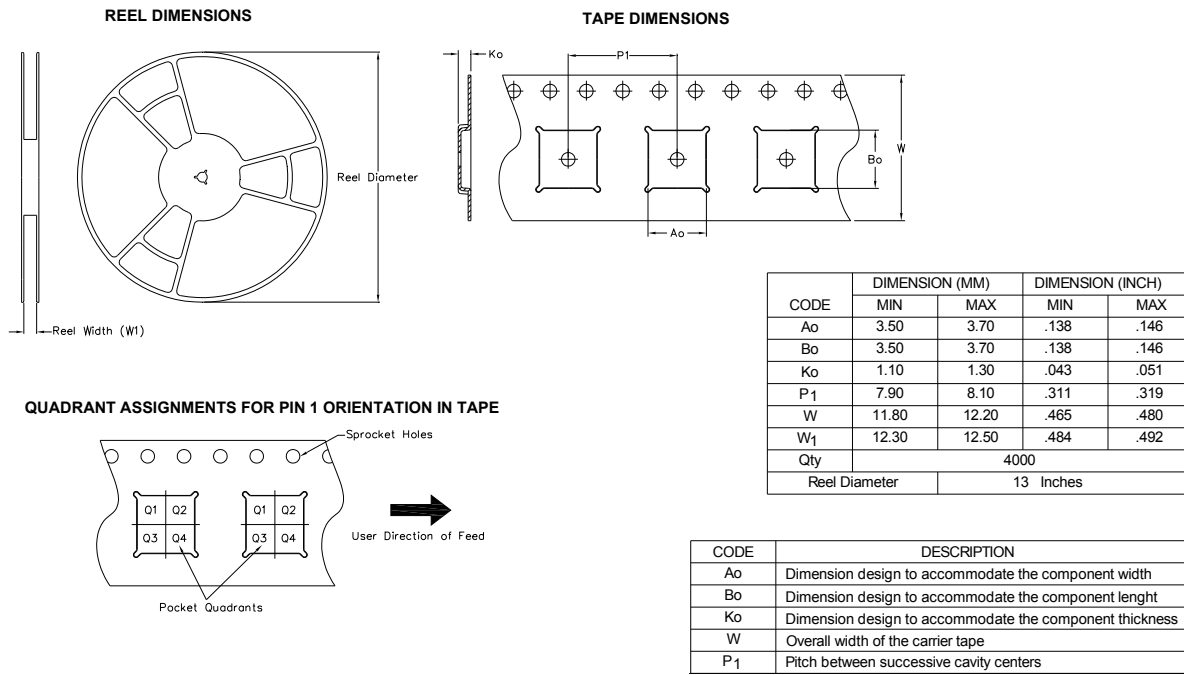
For more information on board mounting, including footprint and stencil recommendation, please refer to application note AN-1136: <http://www.irf.com/technical-info/appnotes/an-1136.pdf>

For more information on package inspection techniques, please refer to application note AN-1154: <http://www.irf.com/technical-info/appnotes/an-1154.pdf>

## PQFN 3.3 x 3.3 Part Marking



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

**PQFN 3.3 x 3.3 Tape and Reel**


Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>



**Qualification Information<sup>†</sup>**

|                                   |                    |                                               |
|-----------------------------------|--------------------|-----------------------------------------------|
| <b>Moisture Sensitivity Level</b> | PQFN 3.3mm x 3.3mm | MSL1<br>(per JEDEC J-STD-020D <sup>††</sup> ) |
| <b>RoHS Compliant</b>             | Yes                |                                               |

<sup>†</sup> Qualification standards can be found at International Rectifier's web site: <http://www.irf.com/product-info/reliability>

<sup>††</sup> Applicable version of JEDEC standard at the time of product release.

**Notes:**

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25^{\circ}\text{C}$ ,  $L = 0.275\text{mH}$ ,  $R_G = 50\Omega$ ,  $I_{AS} = 30\text{A}$ .
- ③ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ④  $R_{\theta}$  is measured at  $T_J$  of approximately  $90^{\circ}\text{C}$ .
- ⑤ When mounted on 1 inch square PCB (FR-4). Please refer to AN-994 for more details:  
<http://www.irf.com/technical-info/appnotes/an-994.pdf>
- ⑥ Calculated continuous current based on maximum allowable junction temperature.
- ⑦ Current is limited to 60A by source bonding technology.
- ⑧ Pulse drain current is limited at 240A by source bonding technology.

**Revision History**

| Date     | Comments                                                                                                                                                                                                                                                     |
|----------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 08/07/13 | <ul style="list-style-type: none"> <li>Added "Fast/RFET™" above part number, on page1</li> </ul>                                                                                                                                                             |
| 12/5/13  | <ul style="list-style-type: none"> <li>Updated fig.14, limit curve to 40A package limitation current, on page 5</li> </ul>                                                                                                                                   |
| 6/3/14   | <ul style="list-style-type: none"> <li>Updated IC @ TC 25C from "40A" to "60A" on page 1, 2</li> <li>Updated schematic on page 1</li> <li>Updated fig 8 and 9 on page 4</li> <li>Updated fig14 on page 5</li> <li>Updated Tape and Reel on page 8</li> </ul> |

International  
 Rectifier

**IR WORLD HEADQUARTERS:** 101 N. Sepulveda Blvd., El Segundo, California 90245, USA

To contact International Rectifier, please visit <http://www.irf.com/whoto-call/>